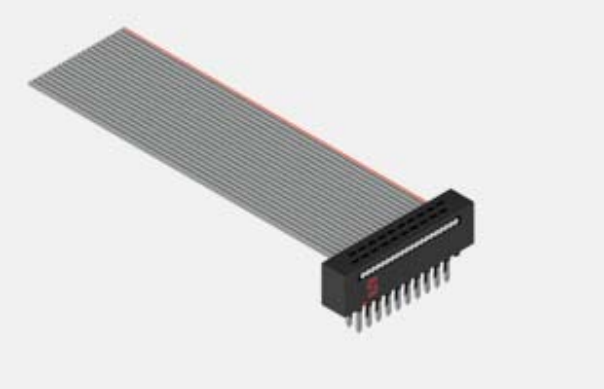
Project Number: Design Qualification Test Report	Tracking Code: 337657_Report_Rev_1
Requested by: Catie Eichhorn	Date: 4/7/2015
Part #: FFMD-15-S-06.00-01-L/SFMC-115-02-L-D	
Part description: FFMD/SFMC	Tech: Kason He
Test Start: 10/9/2014	Test Completed: 11/17/2014



DESIGN QUALIFICATION TEST REPORT

FFMD/SFMC
FFMD-15-S-06.00-01-L/SFMC-115-02-L-D

REVISION HISTORY

DATE	REV.NUM.	DESCRIPTION	ENG
4/7/2015	**1**	**Initial Issue**	**KH**

CERTIFICATION

All instruments and measuring equipment were calibrated to National Institute for Standards and Technology (NIST) traceable standards according to IS0 10012-l and ANSI/NCSL 2540-1, as applicable.

SCOPE

To perform the following tests: Design Qualification test. Please see test plan.

APPLICABLE DOCUMENTS

Standards: EIA Publication 364

TEST SAMPLES AND PREPARATION

1) All materials were manufactured in accordance with the applicable product specification.
2) All test samples were identified and encoded to maintain traceability throughout the test sequences.
3) After soldering, the parts to be used for LLCR testing were cleaned according to TLWI-0001.
4) Either an automated cleaning procedure or an ultrasonic cleaning procedure may be used.
5) The automated procedure is used with aqueous compatible soldering materials.
6) Parts not intended for testing LLCR are visually inspected and cleaned if necessary.
7) Any additional preparation will be noted in the individual test sequences.
8) Solder Information: Lead Free
9) Samtec Test PCBs used: PCB-106438-TST/PCB-106439-TST//PCB-106440-TST/ PCB-106441-TST

FLOWCHARTS

Gas Tight

Group 1
FFMD-15-S-06.00-01-L
SFMC-115-02-L-D
8 Assemblies

Step	Description
1.	LLCR (2) Max Delta = 15 mOhm
2.	Gas Tight (1)
3.	LLCR (2) Max Delta = 15 mOhm

(1) Gas Tight = EIA-364-36

(2) LLCR = EIA-364-23
Open Circuit Voltage = 20 mV Max
Test Current = 100 mA Max

Thermal Aging

Group 1
FFMD-15-S-06.00-01-L
SFMC-115-02-L-D
8 Assemblies

Note: Glue down cap to adequately measure mating/unmating forces

Step	Description
1.	Contact Gaps
2.	Mating/Unmating Force (2)
3.	Thermal Age (3)
4.	Mating/Unmating Force (2)
5.	Contact Gaps

Group 2
FFMD-15-S-06.00-01-L
SFMC-115-02-L-D
8 Assemblies

Step	Description
1.	Contact Gaps
2.	LLCR (1) Max Delta = 15 mOhm
3.	Thermal Age (3)
4.	LLCR (1) Max Delta = 15 mOhm
5.	Contact Gaps

(1) LLCR = EIA-364-23
Open Circuit Voltage = 20 mV Max
Test Current = 100 mA Max

(2) Mating/Unmating Force = EIA-364-13

(3) Thermal Age = EIA-364-17
Test Condition = 4 (105°C)
Time Condition = B (250 Hours)

FLOWCHARTS Continued

Mating/Unmating/Durability

Group 1
FFMD-15-S-06.00-01-L
SFMC-115-02-L-D
8 Assemblies

Step	Description
1.	Contact Gaps
2.	Mating/Unmating Force (3)
3.	Cycles Quantity = 25 Cycles
4.	Mating/Unmating Force (3)
5.	Cycles Quantity = 25 Cycles
6.	Mating/Unmating Force (3)
7.	Cycles Quantity = 25 Cycles
8.	Mating/Unmating Force (3)
9.	Cycles Quantity = 25 Cycles
10.	Mating/Unmating Force (3)
11.	Contact Gaps
12.	Thermal Shock (4)
13.	Humidity (1)
14.	Mating/Unmating Force (3)

Group 2
FFMD-25-S-06.00-01-L
SFMC-125-02-L-D
8 Assemblies

Step	Description
1.	Contact Gaps
2.	Mating/Unmating Force (3)
3.	Cycles Quantity = 25 Cycles
4.	Mating/Unmating Force (3)
5.	Cycles Quantity = 25 Cycles
6.	Mating/Unmating Force (3)
7.	Cycles Quantity = 25 Cycles
8.	Mating/Unmating Force (3)
9.	Cycles Quantity = 25 Cycles
10.	Mating/Unmating Force (3)

Group 3
FFMD-05-S-06.00-01-L
SFMC-105-02-L-D
8 Assemblies

Step	Description
1.	Contact Gaps
2.	Mating/Unmating Force (3)
3.	Cycles Quantity = 25 Cycles
4.	Mating/Unmating Force (3)
5.	Cycles Quantity = 25 Cycles
6.	Mating/Unmating Force (3)
7.	Cycles Quantity = 25 Cycles
8.	Mating/Unmating Force (3)
9.	Cycles Quantity = 25 Cycles
10.	Mating/Unmating Force (3)

Group 4
FFMD-15-S-06.00-01-L
SFMC-115-02-L-D
8 Assemblies

Step	Description
1.	Contact Gaps
2.	LLCR (2) Max Delta = 15 mOhm
3.	Cycles Quantity = 100 Cycles
4.	Contact Gaps
5.	LLCR (2) Max Delta = 15 mOhm
6.	Thermal Shock (4)
7.	LLCR (2) Max Delta = 15 mOhm
8.	Humidity (1)
9.	LLCR (2) Max Delta = 15 mOhm
10.	Mating/Unmating Force (3)

(1) Humidity = EIA-364-31
Test Condition = B (240 Hours)
Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)
Test Exceptions: ambient pre-condition and delete steps 7a and 7b

(2) LLCR = EIA-364-23
Open Circuit Voltage = 20 mV Max
Test Current = 100 mA Max

(3) Mating/Unmating Force = EIA-364-13

(4) Thermal Shock = EIA-364-32
Exposure Time at Temperature Extremes = 1/2 Hour
Method A, Test Condition = I (-55°C to +85°C)
Test Duration = A-3 (100 Cycles)

FLOWCHARTS Continued

IR/DWV

Pin-to-Pin

Group 1 FFMD-15-S-06.00-01-L SFMC-115-02-L-D 2 Assemblies		Group 2 FFMD-15-S-06.00-01-L 2 Assemblies		Group 3 SFMC-115-02-L-D 2 Assemblies		Group 4 FFMD-15-S-06.00-01-L SFMC-115-02-L-D 2 Assemblies	
Step	**Description**	**Step**	**Description**	**Step**	**Description**	**Step**	**Description**
1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	IR (4)
						2.	DWV at Test Voltage (1)
						3.	Thermal Shock (5)
						4.	IR (4)
						5.	DWV at Test Voltage (1)
						6.	Humidity (3)
						7.	IR (4)
						8.	DWV at Test Voltage (1)

Row-to-Row

Group 5 FFMD-15-S-06.00-01-L SFMC-115-02-L-D 2 Assemblies		Group 6 FFMD-15-S-06.00-01-L 2 Assemblies		Group 7 SFMC-115-02-L-D 2 Assemblies		Group 8 FFMD-15-S-06.00-01-L SFMC-115-02-L-D 2 Assemblies	
Step	**Description**	**Step**	**Description**	**Step**	**Description**	**Step**	**Description**
1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	DWV Breakdown (2)	1.	IR (4)
						2.	DWV at Test Voltage (1)
						3.	Thermal Shock (5)
						4.	IR (4)
						5.	DWV at Test Voltage (1)
						6.	Humidity (3)
						7.	IR (4)
						8.	DWV at Test Voltage (1)

(1) DWV at Test Voltage = EIA-364-20
Test Condition = 1 (Sea Level)
DWV test voltage is equal to 75% of the lowest breakdown voltage
Test voltage applied for 60 seconds

(2) DWV Breakdown = EIA-364-20
Test Condition = 1 (Sea Level)
DWV test voltage is equal to 75% of the lowest breakdown voltage
Test voltage applied for 60 seconds

(3) Humidity = EIA-364-31
Test Condition = B (240 Hours)
Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)
Test Exceptions: ambient pre-condition and delete steps 7a and 7b

(4) IR = EIA-364-21
Test Condition = 500 Vdc, 2 Minutes Max

(5) Thermal Shock = EIA-364-32
Exposure Time at Temperature Extremes = 1/2 Hour
Method A, Test Condition = I (-55°C to +85°C)
Test Duration = A-3 (100 Cycles)

FLOWCHARTS Continued

Current Carrying Capacity

Group 1
FFMD-25-D-12.00-01-L
SFMC-125-02-L-D
2 Pins Powered
Signal

Step	Description
1.	CCC (1) Rows = 2 Number of Positions = 1

Group 2
FFMD-25-D-12.00-01-L
SFMC-125-02-L-D
4 Pins Powered
Signal

Step	Description
1.	CCC (1) Rows = 2 Number of Positions = 2

Group 3
FFMD-25-D-12.00-01-L
SFMC-125-02-L-D
6 Pins Powered
Signal

Step	Description
1.	CCC (1) Rows = 2 Number of Positions = 3

Group 4
FFMD-25-D-12.00-01-L
SFMC-125-02-L-D
8 Pins Powered
Signal

Step	Description
1.	CCC (1) Number of Positions = 4 Rows = 2

Group 5
FFMD-25-D-12.00-01-L
SFMC-125-02-L-D
50 Pins Powered
Signal

Step	Description
1.	CCC (1) Rows = 2 Number of Positions = 25

(1) CCC = EIA-364-70
Method 2, Temperature Rise Versus Current Curve
(TIN PLATING) - Tabulate calculated current at RT, 65°C, 75°C and 95°C after derating 20% and based on 105°C
(GOLD PLATING) - Tabulate calculated current at RT, 85°C, 95°C and 115°C after derating 20% and based on 125°C

FLOWCHARTS Continued

Mechanical Shock/Random Vibration/LLCR

Group 1
FFMD-15-S-12.00-01-L
SFMC-115-02-L-D
8 Assemblies

Step	Description
1.	LLCR (1) Max Delta = 15 mOhm
2.	Mechanical Shock (2)
3.	Random Vibration (3)
4.	LLCR (1) Max Delta = 15 mOhm

(1) LLCR = EIA-364-23
Open Circuit Voltage = 20 mV Max
Test Current = 100 mA Max

(2) Mechanical Shock = EIA-364-27
Test Condition = C (100 G Peak, 6 milliseconds, Half Sine)
Number of Shocks = 3 Per Direction, Per Axis, 18 Total

(3) Random Vibration = EIA-364-28
Condition = VB (7.56 gRMS Average, 2 Hours/Axis)

Mechanical Shock/Random Vibration/Event Detection

Group 1
FFMD-15-S-12.00-01-L
SFMC-115-02-L-D
60 Points

Step	Description
1.	Nanosecond Event Detection (Mechanical Shock) (1)
2.	Nanosecond Event Detection (Random Vibration) (2)

(1) Nanosecond Event Detection (Mechanical Shock)
Use EIA-364-87 for Nanosecond Event Detection:
Test Condition = F (50 nanoseconds at 10 ohms)
Use EIA-364-27 for Mechanical Shock:
Test Condition = C (100 G Peak, 6 milliseconds, Half Sine)
Number of Shocks = 3 Per Direction, Per Axis, 18 Total

(2) Nanosecond Event Detection (Random Vibration)
Use EIA-364-87 for Nanosecond Event Detection:
Test Condition = F (50 nanoseconds at 10 ohms)
Use EIA-364-28 for Random Vibration:
Condition = VB (7.56 gRMS Average, 2 Hours/Axis)

FLOWCHARTS Continued

Cable Pull

Group 1	
FFMD-15-S-06.00-01-L	
SFMC-115-02-L-D	
5 Assemblies	
0 Degrees	
Step	**Description**
1.	Cable Pull (1)

Group 2	
FFMD-15-S-06.00-01-L	
SFMC-115-02-L-D	
5 Assemblies	
90 Degrees	
Step	**Description**
1.	Cable Pull (1)

(1) Cable Pull = EIA-364-38
Measure and Record Force Required to Failure
Failure = Discontinuity >1 microsecond at 10 ohms

Cable Flex

Group 1	
FFMD-15-D-16.00-01-L	
SFMC-115-02-L-D	
8 Assemblies	
Flat Cable	
Note: Use test voltage from IR/DWV Sequence	
Step	**Description**
1.	IR (3)
2.	DWV at Test Voltage (2)
3.	Cable Flex (1)
4.	Visual Inspection
5.	IR (3)
6.	DWV at Test Voltage (2)

(1) Cable Flex = EIA-364-41
Circular Jacket Cable - to be tested 90° each direction (180° total)
Flat Cable - to be tested 70° each direction (140° total)
Monitor continuity during flex testing
Failure = Discontinuity >1 microsecond at 10 ohms

(2) DWV at Test Voltage = EIA-364-20
Test Condition = 1 (Sea Level)
DWV test voltage is equal to 75% of the lowest breakdown voltage
Test voltage applied for 60 seconds

(3) IR = EIA-364-21
Test Condition = 500 Vdc, 2 Minutes Max

ATTRIBUTE DEFINITIONS

The following is a brief, simplified description of attributes.

THERMAL SHOCK:

1) EIA-364-32, *Thermal Shock (Temperature Cycling) Test Procedure for Electrical Connectors.*
2) Test Condition 1: -55°C to +85°C
3) Test Time: ½ hour dwell at each temperature extreme
4) Number of Cycles: 100
5) All test samples are pre-conditioned at ambient.
6) All test samples are exposed to environmental stressing in the mated condition.

THERMAL:

1) EIA-364-17, *Temperature Life with or without Electrical Load Test Procedure for Electrical Connectors.*
2) Test Condition 4 at 105° C.
3) Test Time Condition B for 250 hours.
4) All test samples are pre-conditioned at ambient.
5) All test samples are exposed to environmental stressing in the mated condition.

HUMIDITY:

1) Reference document: EIA-364-31, *Humidity Test Procedure for Electrical Connectors.*
2) Test Condition B, 240 Hours.
3) Method III, +25° C to + 65° C, 90% to 98% Relative Humidity excluding sub-cycles 7a and 7b.
4) All samples are pre-conditioned at ambient.
5) All test samples are exposed to environmental stressing in the mated condition.

MECHANICAL SHOCK (Specified Pulse):

1) Reference document: EIA-364-27, *Mechanical Shock Test Procedure for Electrical Connectors*
2) Test Condition C
3) Peak Value: 100 G
4) Duration: 6 Milliseconds
5) Wave Form: Half Sine
6) Velocity: 12.3 ft/s
7) Number of Shocks: 3 Shocks / Direction, 3 Axis (18 Total)

VIBRATION:

1) Reference document: EIA-364-28, *Vibration Test Procedure for Electrical Connectors*
2) Test Condition V, Letter B
3) Power Spectral Density: 0.04 G^2 / Hz
4) G 'RMS': 7.56
5) Frequency: 50 to 2000 Hz
6) Duration: 2.0 Hours per axis (3 axis total)

NANOSECOND-EVENT DETECTION:

1) Reference document: EIA-364-87, *Nanosecond-Event Detection for Electrical Connectors*
2) Prior to test, the samples were characterized to assure the low nanosecond event being monitored will trigger the detector.
3) After characterization it was determined the test samples could be monitored for 50 nanosecond events

MATING/UNMATING:

1) Reference document: EIA-364-13, *Mating and Unmating Forces Test Procedure for Electrical Connectors*.
2) The full insertion position was to within 0.003" to 0.004" of the plug bottoming out in the receptacle to prevent damage to the system under test.
3) One of the mating parts is secured to a floating X-Y table to prevent damage during cycling.

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes

TEMPERATURE RISE (Current Carrying Capacity, CCC):

1) EIA-364-70, *Temperature Rise versus Current Test Procedure for Electrical Connectors and Sockets*.
2) When current passes through a contact, the temperature of the contact increases as a result of I^2R (resistive) heating.
3) The number of contacts being investigated plays a significant part in power dissipation and therefore temperature rise.
4) The size of the temperature probe can affect the measured temperature.
5) Copper traces on PC boards will contribute to temperature rise:
    a. Self heating (resistive)
    b. Reduction in heat sink capacity affecting the heated contacts
6) A de-rating curve, usually 20%, is calculated.
7) Calculated de-rated currents at four temperature points are reported:
    a. Ambient
    b. 65^{o} C
    c. 75^{o} C
    d. 95^{o} C
8) Typically, neighboring contacts (in close proximity to maximize heat build up) are energized.
9) The thermocouple (or temperature measuring probe) will be positioned at a location to sense the maximum temperature in the vicinity of the heat generation area.
10) A computer program, *TR 803.exe*, ensures accurate stability for data acquisition.
11) Hook-up wire cross section is larger than the cross section of any connector leads/PC board traces, jumpers, etc.
12) Hook-up wire length is longer than the minimum specified in the referencing standard.

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes

LLCR:

1) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets.*
2) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
3) The following guidelines are used to categorize the changes in LLCR as a result from stressing
    a. <= +5.0 mOhms: ---------- Stable
    b. +5.1 to +10.0 mOhms: ---------- Minor
    c. +10.1 to +15.0 mOhms: ---------- Acceptable
    d. +15.1 to +50.0 mOhms: ---------- Marginal
    e. +50.1 to +2000 mOhms: ---------- Unstable
    f. >+2000 mOhms: ---------- Open Failure

GAS TIGHT:

To provide method for evaluating the ability of the contacting surfaces in preventing penetration of harsh vapors which might lead to oxide formation that may degrade the electrical performance of the contact system.

1) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets.*
2) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
3) The following guidelines are used to categorize the changes in LLCR as a result from stressing
    a. <= +5.0 mOhms: ---------- Stable
    b. +5.1 to +10.0 mOhms: ---------- Minor
    c. +10.1 to +15.0 mOhms: ---------- Acceptable
    d. +15.1 to +50.0 mOhms: ---------- Marginal
    e. +50.1 to +2000 mOhms: ---------- Unstable
    f. >+2000 mOhms: ---------- Open Failure
4) Procedure:
    a. Reference document: EIA-364-36, *Test Procedure for Determination of Gas-Tight Characteristics for Electrical Connectors, Sockets and/or Contact Systems*.
    b. Test Conditions:
        i. Class II--- Mated pairs of contacts assembled to their plastic housings.
        ii. Reagent grade Nitric Acid shall be used of sufficient volume to saturate the test chamber
        iii. The ratio of the volume of the test chamber to the surface area of the acid shall be 10:1.
        iv. The chamber shall be saturated with the vapor for at least 15 minutes before samples are added.
        v. Exposure time, 55 to 65 minutes.
        vi. The samples shall be no closer to the chamber walls than 1 inches and no closer to the surface of the acid than 3 inches.
        vii. The samples shall be dried after exposure for a minimum of 1 hour.
        viii. Drying temperature 50^{o} C
        ix. The final LLCR shall be conducted within 1 hour after drying.

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes

INSULATION RESISTANCE (IR):

To determine the resistance of insulation materials to leakage of current through or on the surface of these materials when a DC potential is applied.

1) PROCEDURE:
    a. Reference document: EIA-364-21, *Insulation Resistance Test Procedure for Electrical Connectors*.
    b. Test Conditions:
        i. Between Adjacent Contacts or Signal-to-Ground
        ii. Electrification Time 2.0 minutes
        iii. Test Voltage (500 VDC) corresponds to calibration settings for measuring resistances.
2) MEASUREMENTS:
3) When the specified test voltage is applied (VDC), the insulation resistance shall not be less than 1000 megohms.

DIELECTRIC WITHSTANDING VOLTAGE (DWV):

To determine if the sockets can operate at its rated voltage and withstand momentary over potentials due to switching, surges, and other similar phenomenon. Separate samples are used to evaluate the effect of environmental stresses so not to influence the readings from arcing that occurs during the measurement process.

1) PROCEDURE:
    a. Reference document: EIA-364-20, *Withstanding Voltage Test Procedure for Electrical Connectors*.
    b. Test Conditions:
        i. Between Adjacent Contacts or Signal-to-Ground
        ii. Barometric Test Condition 1
        iii. Rate of Application 500 V/Sec
        iv. Test Voltage (VAC) until breakdown occurs
2) MEASUREMENTS/CALCULATIONS
    a. The breakdown voltage shall be measured and recorded.
    b. The dielectric withstanding voltage shall be recorded as 75% of the minimum breakdown voltage.
    c. The working voltage shall be recorded as one-third (1/3) of the dielectric withstanding voltage (one-fourth of the breakdown voltage).

ATTRIBUTE DEFINITIONS

The following is a brief, simplified description of attributes.

CONNECTOR PULL:

1) Secure cable near center and pull on connector
    a. At 90°, right angle to cable
    b. At 0°, in-line with cable

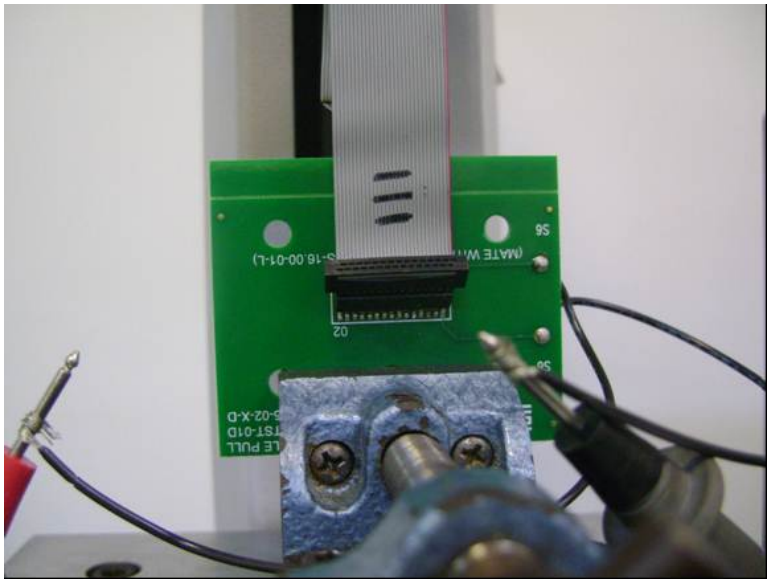


Fig. 1
90° Connector pull, notice the electrical continuity hook-up wires.

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes

CABLE DURABILITY:

a. 90° Flex Mode, bend up to 500 cycles with 4.0 oz. load on cable end.

Fig. 2

RESULTS

Temperature Rise, CCC at a 20% de-rating

- **CCC for a 30°C Temperature Rise----------2.5 A per contact with 2 power contacts (2x1) powered**
- **CCC for a 30°C Temperature Rise----------1.9 A per contact with 4 power contacts (2x2) powered**
- **CCC for a 30°C Temperature Rise----------1.6 A per contact with 6 power contacts (2x3) powered**
- **CCC for a 30°C Temperature Rise----------1.5 A per contact with 8 power contacts (2x4) powered**
- **CCC for a 30°C Temperature Rise----------0.9 A per contact with 50 power contacts (2x25) powered**

Mating/Unmating Forces: Thermal Aging Group

- **Initial**
  - **Mating**
    - **Min ---------- 5.68 Lbs**
    - **Max---------- 6.98 Lbs**
  - **Unmating**
    - **Min ---------- 4.05 Lbs**
    - **Max---------- 5.87 Lbs**
- **After Thermal**
  - **Mating**
    - **Min ---------- 5.31 Lbs**
    - **Max---------- 5.79 Lbs**
  - **Unmating**
    - **Min ---------- 4.30 Lbs**
    - **Max---------- 4.64 Lbs**

RESULTS Continued

Mating/Unmating Forces: Mating/Unmating Durability Group

FFMD-15-S-06.00-01-L/SFMC-115-02-L-D

- **Initial**
  - **Mating**
    - **Min ---------- 5.54 Lbs**
    - **Max---------- 7.47 Lbs**
  - **Unmating**
    - **Min ---------- 4.63 Lbs**
    - **Max---------- 6.13 Lbs**
- **After 25 Cycles**
  - **Mating**
    - **Min ---------- 7.61 Lbs**
    - **Max---------- 9.95 Lbs**
  - **Unmating**
    - **Min ---------- 6.31 Lbs**
    - **Max---------- 8.58 Lbs**
- **After 50 Cycles**
  - **Mating**
    - **Min ---------- 9.50 Lbs**
    - **Max----------11.81 Lbs**
  - **Unmating**
    - **Min ---------- 7.85 Lbs**
    - **Max----------10.31 Lbs**
- **After 75 Cycles**
  - **Mating**
    - **Min ----------10.30 Lbs**
    - **Max----------12.93 Lbs**
  - **Unmating**
    - **Min ---------- 8.78 Lbs**
    - **Max----------11.11 Lbs**
- **After 100 Cycles**
  - **Mating**
    - **Min ----------11.16 Lbs**
    - **Max----------13.64 Lbs**
  - **Unmating**
    - **Min ---------- 9.83 Lbs**
    - **Max----------11.73 Lbs**
- **After Humidity**
  - **Mating**
    - **Min ---------- 4.40 Lbs**
    - **Max---------- 5.09 Lbs**
  - **Unmating**
    - **Min ---------- 3.83 Lbs**
    - **Max---------- 4.44 Lbs**

RESULTS Continued

Mating/Unmating Forces: Mating/Unmating Basic Group

FFMD-25-S-06.00-01-L/SFMC-125-02-L-D

- **Initial**
  - **Mating**
    - **Min ---------- 9.81 Lbs**
    - **Max----------11.66 Lbs**
  - **Unmating**
    - **Min ---------- 8.36 Lbs**
    - **Max----------10.00 Lbs**
- **After 25 Cycles**
  - **Mating**
    - **Min ----------12.73 Lbs**
    - **Max----------15.24 Lbs**
  - **Unmating**
    - **Min ----------10.51 Lbs**
    - **Max----------12.72 Lbs**
- **After 50 Cycles**
  - **Mating**
    - **Min ----------15.64 Lbs**
    - **Max----------18.89 Lbs**
  - **Unmating**
    - **Min ----------13.18 Lbs**
    - **Max----------16.13 Lbs**
- **After 75 Cycles**
  - **Mating**
    - **Min ----------17.83 Lbs**
    - **Max----------20.72 Lbs**
  - **Unmating**
    - **Min ----------15.11 Lbs**
    - **Max----------17.89 Lbs**
- **After 100 Cycles**
  - **Mating**
    - **Min ----------19.38 Lbs**
    - **Max----------21.70 Lbs**
  - **Unmating**
    - **Min ----------16.37 Lbs**
    - **Max----------19.27 Lbs**

RESULTS Continued

Mating/Unmating Forces: Mating/Unmating Basic Group

FFMD-05-S-06.00-01-L/SFMC-105-02-L-D

- **Initial**
  - **Mating**
    - **Min ---------- 1.78 Lbs**
    - **Max---------- 2.17 Lbs**
  - **Unmating**
    - **Min ---------- 1.40 Lbs**
    - **Max---------- 1.75 Lbs**
- **After 25 Cycles**
  - **Mating**
    - **Min ---------- 2.01 Lbs**
    - **Max---------- 2.83 Lbs**
  - **Unmating**
    - **Min ---------- 1.59 Lbs**
    - **Max---------- 1.89 Lbs**
- **After 50 Cycles**
  - **Mating**
    - **Min ---------- 1.95 Lbs**
    - **Max---------- 2.79 Lbs**
  - **Unmating**
    - **Min ---------- 1.54 Lbs**
    - **Max---------- 2.12 Lbs**
- **After 75 Cycles**
  - **Mating**
    - **Min ---------- 2.01 Lbs**
    - **Max---------- 2.96 Lbs**
  - **Unmating**
    - **Min ---------- 1.63 Lbs**
    - **Max---------- 2.44 Lbs**
- **After 100 Cycles**
  - **Mating**
    - **Min ---------- 2.03 Lbs**
    - **Max---------- 3.11 Lbs**
  - **Unmating**
    - **Min ---------- 1.61 Lbs**
    - **Max---------- 2.69 Lbs**

RESULTS Continued

Insulation Resistance minimums, IR

Pin to Pin

- **Initial**
  - **Mated ---------- 10000 Meg Ω ---------- Passed**
  - **Unmated ---------- 10000 Meg Ω ---------- Passed**
- **Thermal**
  - **Mated ---------- 10000 Meg Ω ---------- Passed**
  - **Unmated ---------- 10000 Meg Ω ---------- Passed**
- **Humidity**
  - **Mated ---------- 10000 Meg Ω ---------- Passed**
  - **Unmated ---------- 10000 Meg Ω ---------- Passed**

Row to Row

- **Initial**
  - **Mated ---------- 10000 Meg Ω ---------- Passed**
  - **Unmated ---------- 10000 Meg Ω ---------- Passed**
- **Thermal**
  - **Mated ---------- 10000 Meg Ω ---------- Passed**
  - **Unmated ---------- 10000 Meg Ω ---------- Passed**
- **Humidity**
  - **Mated ---------- 10000 Meg Ω ---------- Passed**
  - **Unmated ---------- 10000 Meg Ω ---------- Passed**

Dielectric Withstanding Voltage minimums, DWV

- **Minimums**
  - **Breakdown Voltage ---------- 875 VAC**
  - **Test Voltage ---------- 656 VAC**
  - **Working Voltage ---------- 215 VAC**

Pin to Pin

- **Initial DWV ---------- Passed**
- **Thermal DWV ---------- Passed**
- **Humidity DWV ---------- Passed**

Row to Row

- **Initial DWV ---------- Passed**
- **Thermal DWV ---------- Passed**
- **Humidity DWV ---------- Passed**

RESULTS Continued

LLCR Gas Tight (192 LLCR test points)

- **Initial ---------- 54.72 mOhms Max**
- **Gas-Tight**
  - **<= +5.0 mOhms ---------- 191 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 1 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**

LLCR Thermal Aging (192 LLCR test points)

- **Initial ---------- 62.28 mOhms Max**
- **Thermal Aging**
  - **<= +5.0 mOhms ---------- 190 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 2 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**

LLCR Durability (192 LLCR test points)

- **Initial ---------- 62.62 mOhms Max**
- **Durability, 100 Cycles**
  - **<= +5.0 mOhms ---------- 189 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 3 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**
- **Thermal**
  - **<= +5.0 mOhms ---------- 146 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 46 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**
- **Humidity**
  - **<= +5.0 mOhms ---------- 133 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 53 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 6 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**

RESULTS Continued

LLCR Shock & Vibration (192 LLCR test points)

- **Initial ---------- 106.04 mOhms Max**
- **Shock &Vibration**
  - **<= +5.0 mOhms ---------- 186 Points ---------- Stable**
  - **+5.1 to +10.0 mOhms ---------- 6 Points ---------- Minor**
  - **+10.1 to +15.0 mOhms ---------- 0 Points ---------- Acceptable**
  - **+15.1 to +50.0 mOhms ---------- 0 Points ---------- Marginal**
  - **+50.1 to +2000 mOhms ---------- 0 Points ---------- Unstable**
  - **>+2000 mOhms ---------- 0 Points ---------- Open Failure**

Mechanical Shock & Random Vibration:

- **Shock**
  - **No Damage ---------- ---------- Pass**
  - **50 Nanoseconds ---------- ---------- Pass**
- **Vibration**
  - **No Damage ---------- ---------- Pass**
  - **50 Nanoseconds ---------- ---------- Pass**

Cable Pull

- **0 ° Pull force**
  - **Min ---------- 10.07 Lbs**
  - **Max ---------- 12.19 Lbs**
- **90 ° Pull force**
  - **Min ---------- 8.62 Lbs**
  - **Max ---------- 9.14 Lbs**

Cable Flex

IR

Pin to Pin

- **Initial**
  - **Mated ---------- 45000 Meg Ω ---------- Passed**
- **After 500 Flex cycles**
  - **Mated ---------- 45000 Meg Ω ---------- Passed**

Row to Row

- **Initial**
  - **Mated ---------- 45000 Meg Ω ---------- Passed**
- **After 500 Flex cycles**
  - **Mated ---------- 45000 Meg Ω ---------- Passed**

DWV

Pin to Pin

- **Initial DWV ---------- ---------- Passed**
- **500 Flex cycles DWV ---------- Passed**

Row to Row

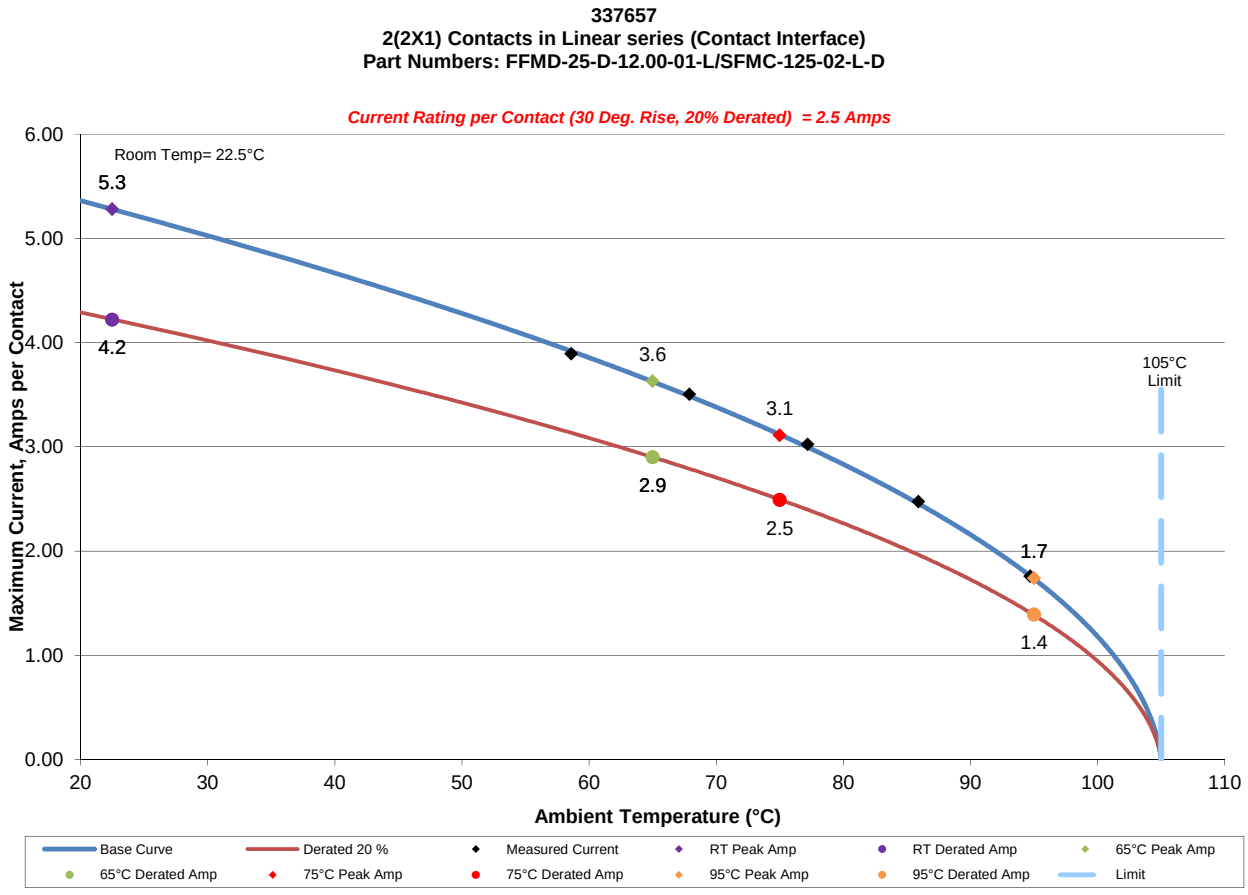
- **Initial DWV ---------- ---------- Passed**
- **500 Flex cycles DWV ---------- Passed**

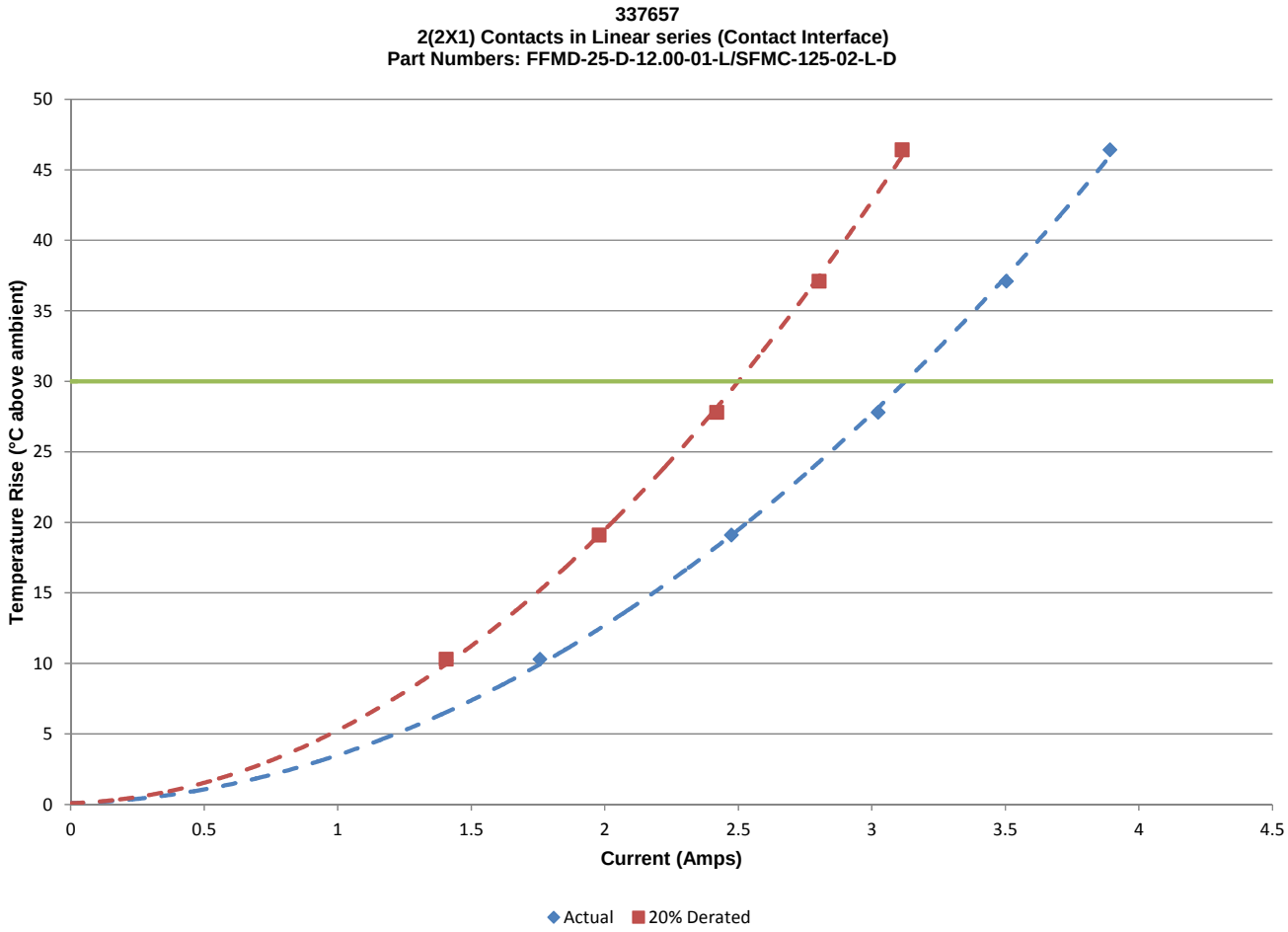
DATA SUMMARIES

TEMPERATURE RISE (Current Carrying Capacity, CCC):

1) High quality thermocouples whose temperature slopes track one another were used for temperature monitoring.
2) The thermocouples were placed at a location to sense the maximum temperature generated during testing.
3) Temperature readings recorded are those for which three successive readings, 15 minutes apart, differ less than 1° C (computer controlled data acquisition).
4) Adjacent contacts were powered:

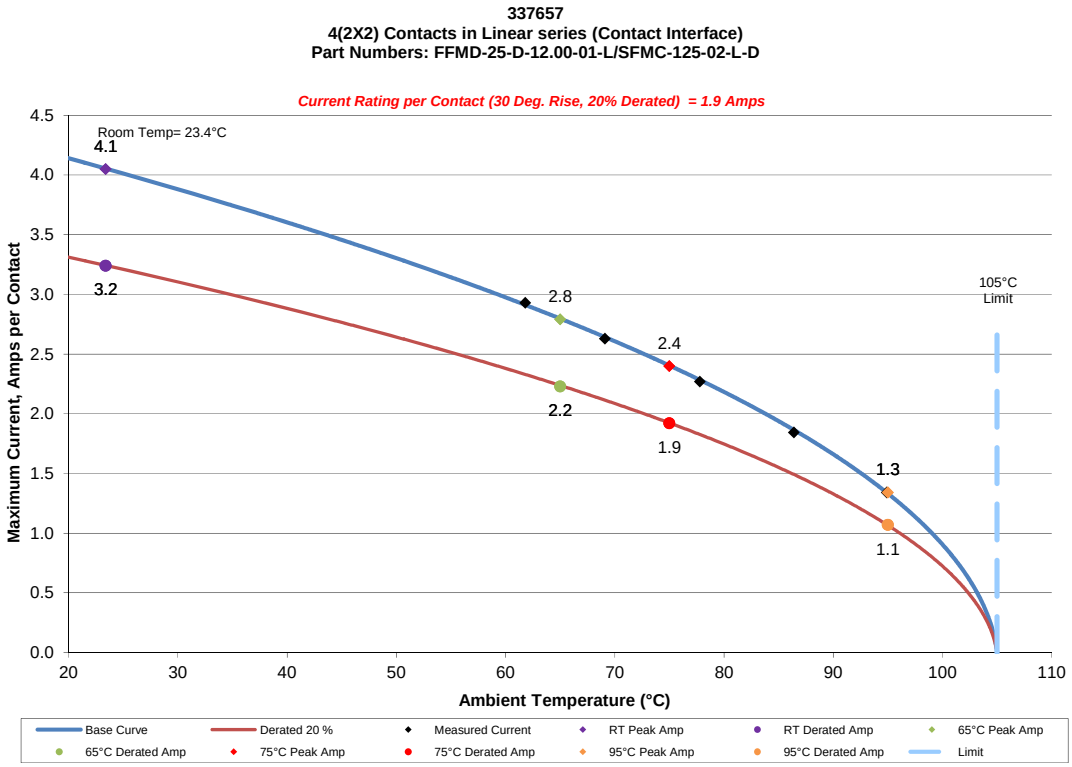
    a. Linear configuration with 2 adjacent conductors/contacts powered

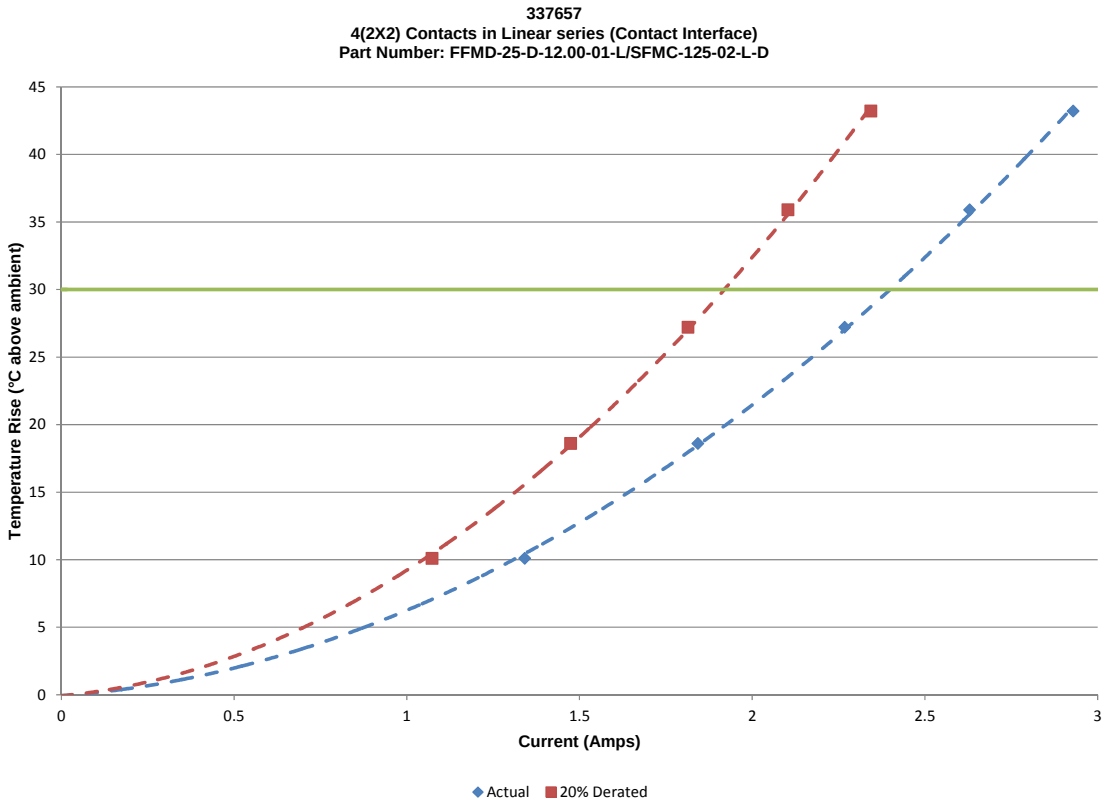



337657
2(2X1) Contacts in Linear series (Contact Interface)
Part Numbers: FFMD-25-D-12.00-01-L/SFMC-125-02-L-D
Temperature Rise (°C above ambient)
Current (Amps)
0
5
10
15
20
25
30
35
40
45
50
0
0.5
1
1.5
2
2.5
3
3.5
4
4.5
Actual
20% Derated

DATA SUMMARIES Continued

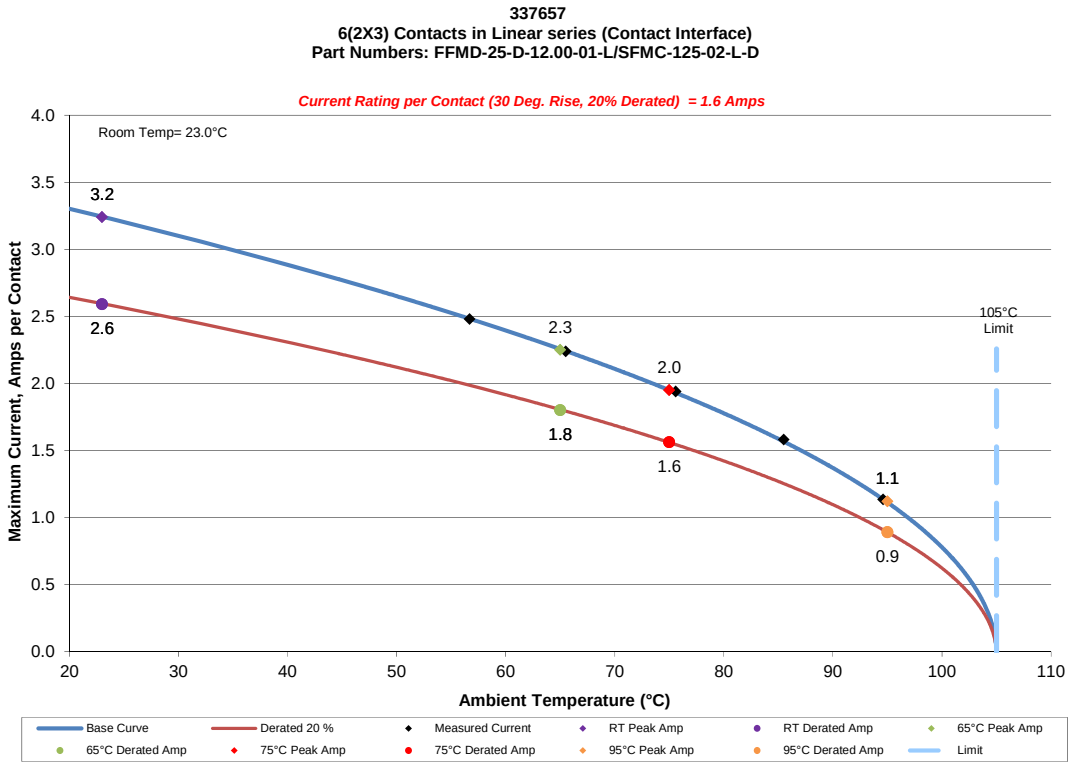
b. Linear configuration with 4 adjacent conductors/contacts powered

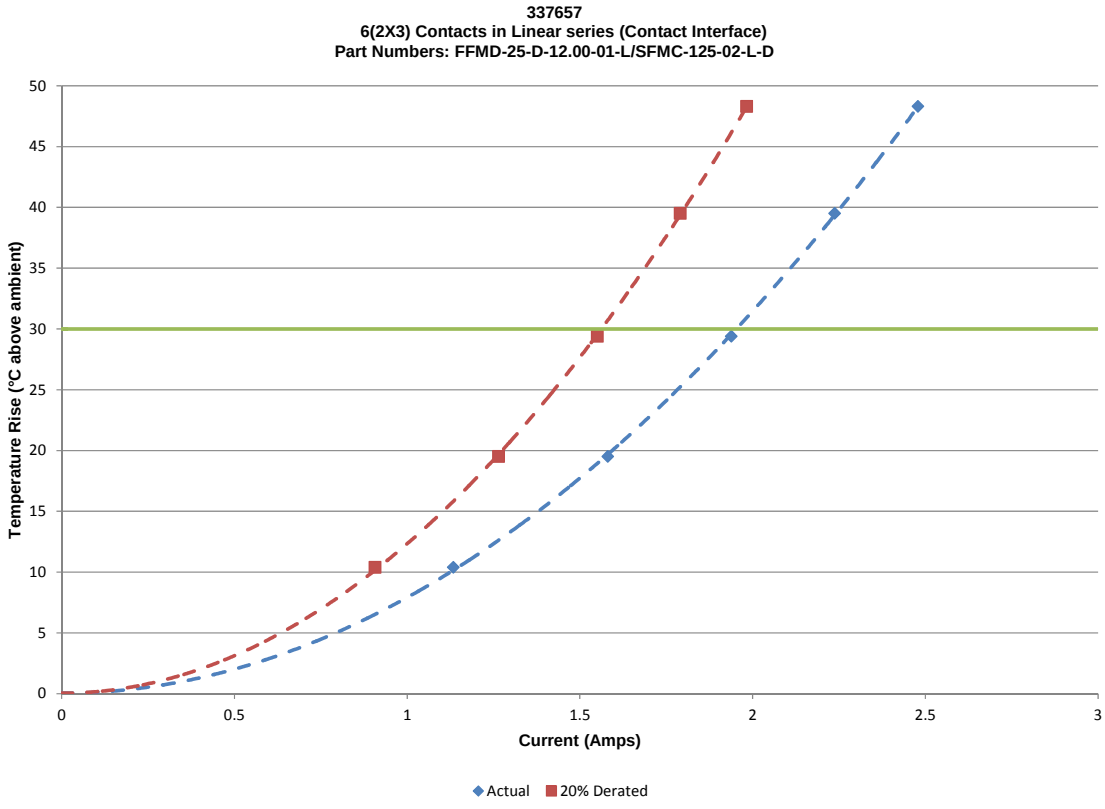




DATA SUMMARIES Continued

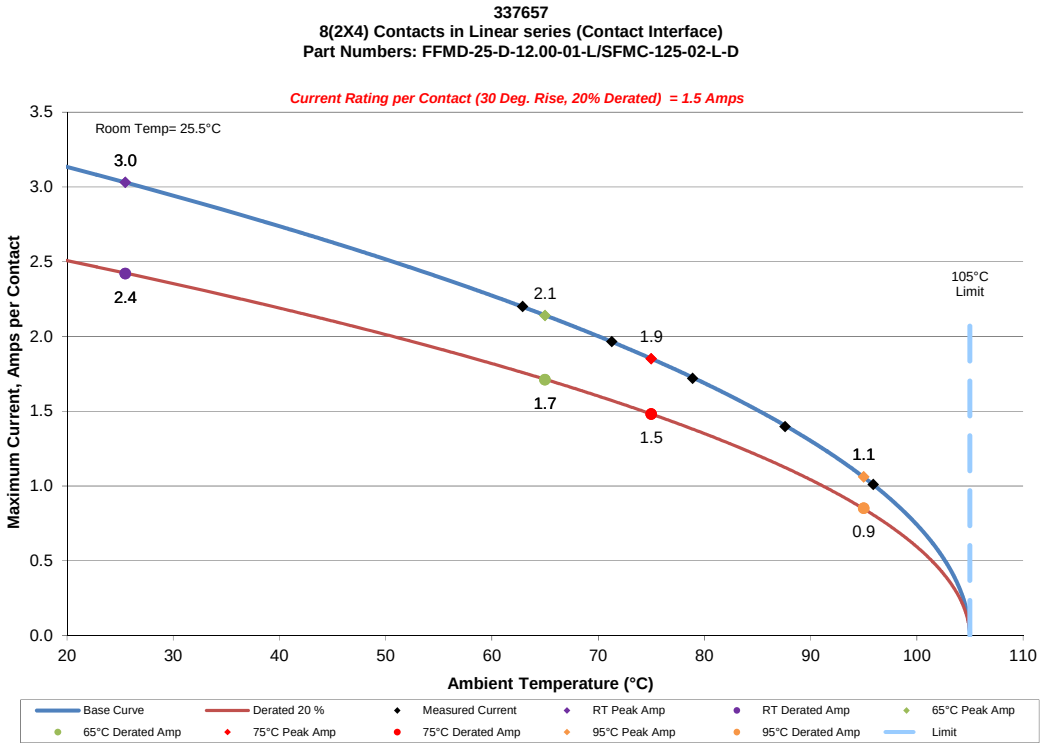
c. Linear configuration with 6 adjacent conductors/contacts powered

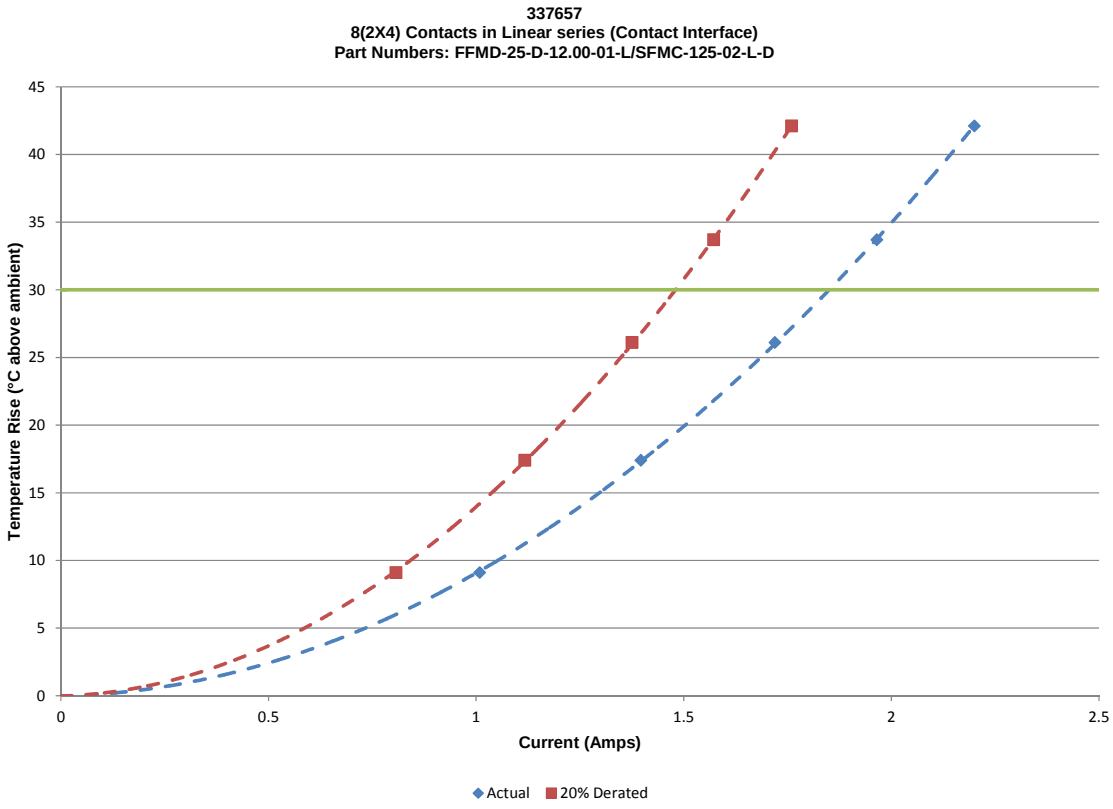




DATA SUMMARIES Continued

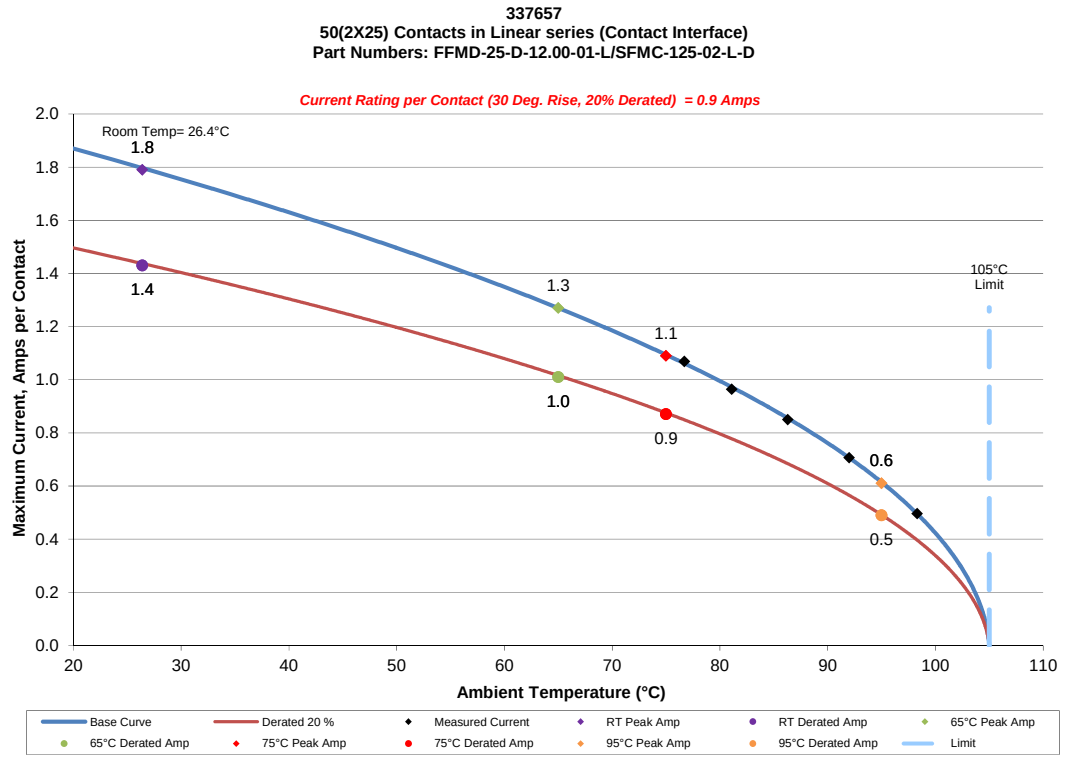
d. Linear configuration with 8 adjacent conductors/contacts powered

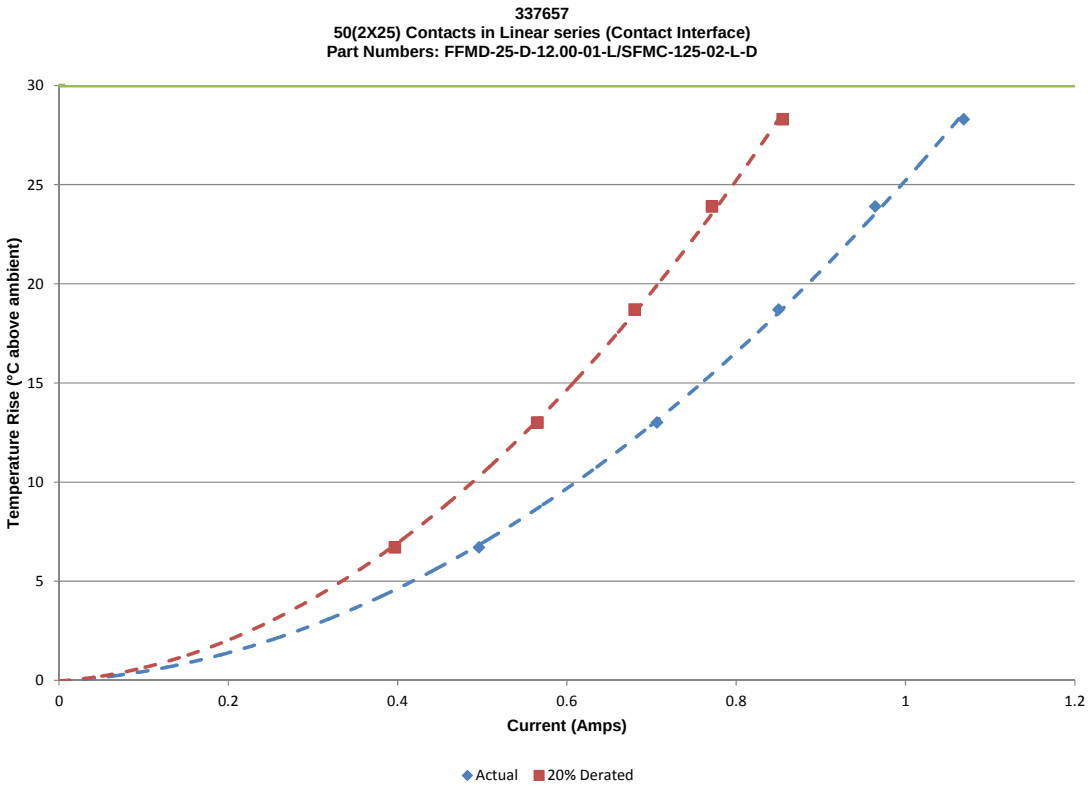




DATA SUMMARIES Continued

e. Linear configuration with all adjacent conductors/contacts powered





DATA SUMMARIES Continued

Mating\Unmating Force: Thermal Aging Group

	Initial				After Thermals			
	Mating		**Unmating**		**Mating**		**Unmating**	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	25.26	5.68	18.01	4.05	23.62	5.31	19.13	4.30
Maximum	31.05	6.98	26.11	5.87	25.75	5.79	20.64	4.64
Average	28.03	**6.30**	22.89	**5.15**	24.42	**5.49**	19.95	**4.49**
St Dev	2.18	0.49	2.52	0.57	0.62	0.14	0.49	0.11
Count	8	8	8	8	8	8	8	8

Mating\Unmating Force: Mating\Unmating Durability Group

FFMD-15-S-06.00-01-L/SFMC-115-02-L-D

	Initial				After 25 Cycles			
	Mating		**Unmating**		**Mating**		**Unmating**	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	24.64	5.54	20.59	4.63	33.85	7.61	28.07	6.31
Maximum	33.23	7.47	27.27	6.13	44.26	9.95	38.16	8.58
Average	28.22	**6.34**	23.80	**5.35**	39.19	**8.81**	32.95	**7.41**
St Dev	2.80	0.63	2.07	0.46	3.46	0.78	3.17	0.71
Count	8	8	8	8	8	8	8	8
	After 50 Cycles				After 75 Cycles			
	Mating		**Unmating**		**Mating**		**Unmating**	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	42.26	9.50	34.92	7.85	45.81	10.30	39.05	8.78
Maximum	52.53	11.81	45.86	10.31	57.51	12.93	49.42	11.11
Average	47.08	**10.59**	40.07	**9.01**	51.84	**11.65**	44.41	**9.98**
St Dev	3.58	0.81	3.21	0.72	3.70	0.83	2.99	0.67
Count	8	8	8	8	8	8	8	8
	After 100 Cycles				After Humidity			
	Mating		**Unmating**		**Mating**		**Unmating**	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	49.64	11.16	43.72	9.83	19.57	4.40	17.04	3.83
Maximum	60.67	13.64	52.18	11.73	22.64	5.09	19.75	4.44
Average	54.97	**12.36**	47.28	**10.63**	20.53	**4.62**	17.84	**4.01**
St Dev	3.90	0.88	3.04	0.68	0.99	0.22	0.88	0.20
Count	8	8	8	8	8	8	8	8

DATA SUMMARIES Continued

Mating\Unmating Force: Mating\Unmating Basic Group

FFMD-25-S-06.00-01-L/SFMC-125-02-L-D

	Initial				After 25 Cycles			
	Mating		**Unmating**		**Mating**		**Unmating**	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	43.63	9.81	37.19	8.36	56.62	12.73	46.75	10.51
Maximum	51.86	11.66	44.48	10.00	67.79	15.24	56.58	12.72
Average	46.00	**10.34**	39.06	**8.78**	60.98	**13.71**	51.37	**11.55**
St Dev	2.59	0.58	2.53	0.57	3.23	0.73	3.97	0.89
Count	8	8	8	8	8	8	8	8

	After 50 Cycles				After 75 Cycles			
	Mating		**Unmating**		**Mating**		**Unmating**	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	69.57	15.64	58.62	13.18	79.31	17.83	67.21	15.11
Maximum	84.02	18.89	71.75	16.13	92.16	20.72	79.57	17.89
Average	73.39	**16.50**	63.80	**14.34**	82.73	**18.60**	71.83	**16.15**
St Dev	4.99	1.12	5.39	1.21	4.58	1.03	4.37	0.98
Count	8	8	8	8	8	8	8	8

	After 100 Cycles			
	Mating		**Unmating**	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	86.20	19.38	72.81	16.37
Maximum	96.52	21.70	85.71	19.27
Average	89.28	**20.07**	76.95	**17.30**
St Dev	4.08	0.92	4.57	1.03
Count	8	8	8	8

DATA SUMMARIES Continued

Mating\Unmating Force: Mating\Unmating Basic Group

FFMD-05-S-06.00-01-L/SFMC-105-02-L-D

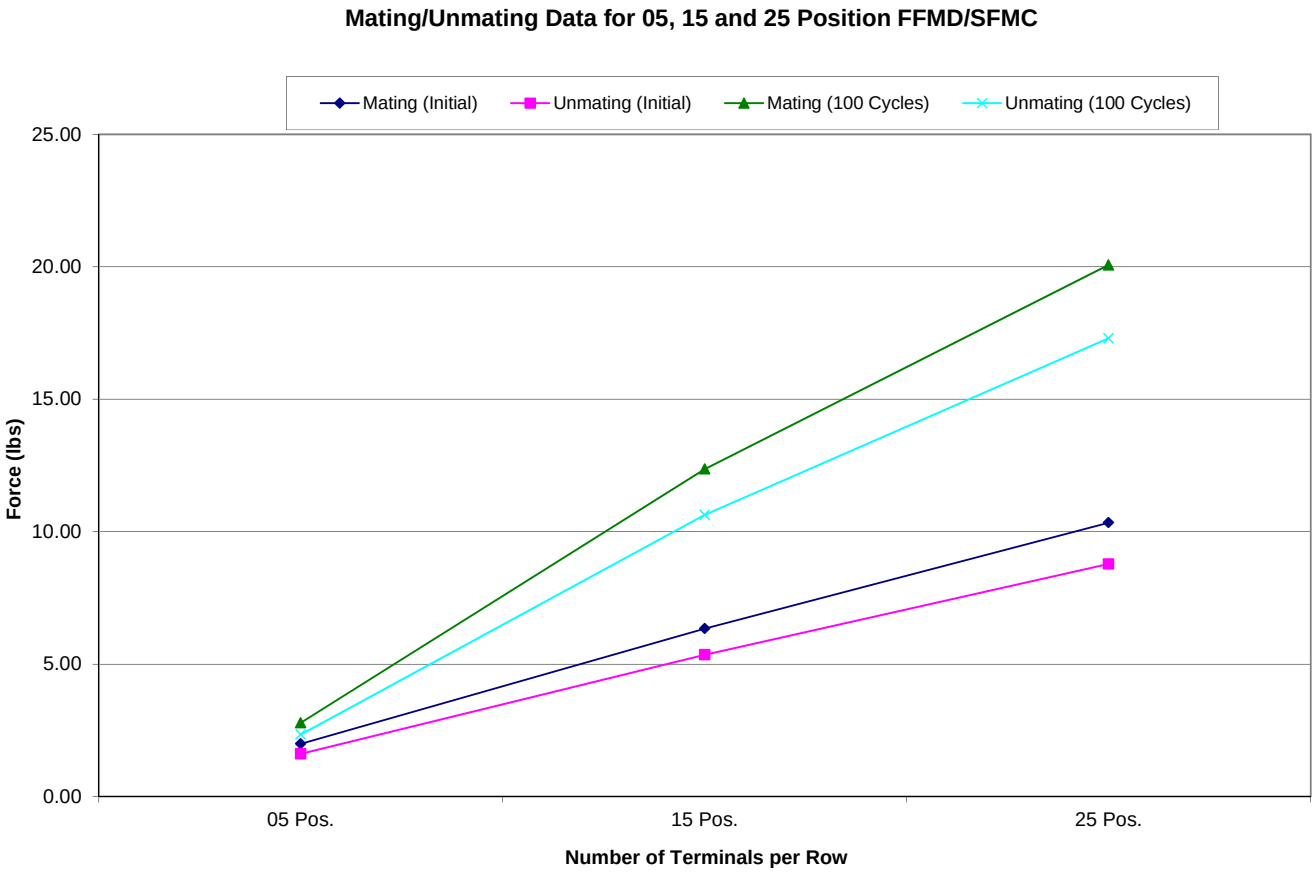
	Initial				After 25 Cycles			
	Mating		**Unmating**		**Mating**		**Unmating**	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	7.92	1.78	6.23	1.40	8.94	2.01	7.07	1.59
Maximum	9.65	2.17	7.78	1.75	12.59	2.83	8.41	1.89
Average	8.83	**1.99**	7.16	**1.61**	10.37	**2.33**	7.95	**1.79**
St Dev	0.68	0.15	0.53	0.12	1.15	0.26	0.50	0.11
Count	8	8	8	8	8	8	8	8

	After 50 Cycles				After 75 Cycles			
	Mating		**Unmating**		**Mating**		**Unmating**	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	8.67	1.95	6.85	1.54	8.94	2.01	7.25	1.63
Maximum	12.41	2.79	9.43	2.12	13.17	2.96	10.85	2.44
Average	10.80	**2.43**	8.78	**1.97**	11.78	**2.65**	9.68	**2.18**
St Dev	1.11	0.25	0.85	0.19	1.49	0.33	1.22	0.27
Count	8	8	8	8	8	8	8	8

	After 100 Cycles			
	Mating		**Unmating**	
	Newtons	Force (Lbs)	Newtons	Force (Lbs)
Minimum	9.03	2.03	7.16	1.61
Maximum	13.83	3.11	11.97	2.69
Average	12.38	**2.78**	10.43	**2.34**
St Dev	1.74	0.39	1.64	0.37
Count	8	8	8	8

DATA SUMMARIES Continued

Mating\Unmating Force Comparison



DATA SUMMARIES Continued

INSULATION RESISTANCE (IR):

	Pin to Pin		
	Mated	Unmated	Unmated
Minimum	**FFMD/SFMC**	**FFMD**	**SFMC**
Initial	10000	10000	10000
Thermal	10000	10000	10000
Humidity	10000	10000	10000

	Row to Row		
	Mated	Unmated	Unmated
Minimum	**FFMD/SFMC**	**FFMD**	**SFMC**
Initial	10000	10000	10000
Thermal	10000	10000	10000
Humidity	10000	10000	10000

DIELECTRIC WITHSTANDING VOLTAGE (DWV):

Voltage Rating Summary	
Minimum	**FFMD/SFMC**
Break Down Voltage	875
Test Voltage	656
Working Voltage	215

Pin to Pin	
Initial Test Voltage	Passed
After Thermal Test Voltage	Passed
After Humidity Test Voltage	Passed

Row to Row	
Initial Test Voltage	Passed
After Thermal Test Voltage	Passed
After Humidity Test Voltage	Passed

DATA SUMMARIES Continued

LLCR Durability:

1) A total of 192 points were measured.
2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets.*
3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
   a. <= +5.0 mOhms:---------- Stable
   b. +5.1 to +10.0 mOhms: ---------- Minor
   c. +10.1 to +15.0 mOhms: ---------- Acceptable
   d. +15.1 to +50.0 mOhms: ---------- Marginal
   e. +50.1 to +2000 mOhms---------- Unstable
   f. >+2000 mOhms:---------- Open Failure

LLCR Measurement Summaries by Pin Type				
Date	2014/10/13	2014/10/17	2014/10/24	2014/11/5
Room Temp (Deg C)	22	22	23	22
Rel Humidity (%)	48	47	51	48
Technician	Kason He	Kason He	Kason He	Kason He
mOhm values	**Actual Initial**	**Delta 100 Cycles**	**Delta Therm Shck**	**Delta Humidity**
	Pin Type 1: Signal			
Average	50.18	1.20	3.52	4.15
St. Dev.	2.17	1.04	2.00	2.50
Min	46.66	0.04	0.01	0.14
Max	62.62	5.65	9.03	12.13
Summary Count	192	192	192	192
Total Count	192	192	192	192

LLCR Delta Count by Category						
	Stable	**Minor**	**Acceptable**	**Marginal**	**Unstable**	**Open**
mOhms	**<=5**	**>5 & <=10**	**>10 & <=15**	**>15 & <=50**	**>50 & <=1000**	**>1000**
100 Cycles	**189**	**3**	**0**	**0**	**0**	**0**
Therm Shck	**146**	**46**	**0**	**0**	**0**	**0**
Humidity	**133**	**53**	**6**	**0**	**0**	**0**

DATA SUMMARIES Continued

LLCR Thermal Aging:

1) A total of 192 points were measured.
2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets.*
3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
   a. <= +5.0 mOhms: ---------- Stable
   b. +5.1 to +10.0 mOhms: ---------- Minor
   c. +10.1 to +15.0 mOhms: ---------- Acceptable
   d. +15.1 to +50.0 mOhms: ---------- Marginal
   e. +50.1 to +2000 mOhms: ---------- Unstable
   f. >+2000 mOhms: ---------- Open Failure

	LLCR Measurement Summaries by Pin Type			
Date	2014/10/13	2014/10/27		
Room Temp (Deg C)	22	24		
Rel Humidity (%)	48	51		
Technician	Kason He	Kason He		
mOhm values	**Actual Initial**	**Delta Thermal**	**Delta**	**Delta**
	Pin Type 1: Signal			
Average	50.17	0.79		
St. Dev.	1.83	0.90		
Min	47.00	0.01		
Max	62.28	7.03		
Summary Count	192	192		
Total Count	192	192		

LLCR Delta Count by Category						
	Stable	**Minor**	**Acceptable**	**Marginal**	**Unstable**	**Open**
mOhms	**<=5**	**>5 & <=10**	**>10 & <=15**	**>15 & <=50**	**>50 & <=1000**	**>1000**
Thermal	**190**	**2**	**0**	**0**	**0**	**0**

DATA SUMMARIES Continued

LLCR Gas Tight:

1) A total of 192 points were measured.
2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets.*
3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
   a. <= +5.0 mOhms: ---------- Stable
   b. +5.1 to +10.0 mOhms: ---------- Minor
   c. +10.1 to +15.0 mOhms: ---------- Acceptable
   d. +15.1 to +50.0 mOhms: ---------- Marginal
   e. +50.1 to +2000 mOhms: ---------- Unstable
   f. >+2000 mOhms: ---------- Open Failure

LLCR Measurement Summaries by Pin Type				
Date	2014/10/21	2014/10/23		
Room Temp (Deg C)	22	23		
Rel Humidity (%)	48	49		
Technician	Kason He	Kason He		
mOhm values	**Actual Initial**	**Delta Acid Vapor**	**Delta**	**Delta**
	Pin Type 1: Signal			
Average	50.19	0.97		
St. Dev.	1.42	0.82		
Min	46.48	0.02		
Max	54.72	5.88		
Summary Count	192	192		
Total Count	192	192		

LLCR Delta Count by Category						
	Stable	**Minor**	**Acceptable**	**Marginal**	**Unstable**	**Open**
mOhms	**<=5**	**>5 & <=10**	**>10 & <=15**	**>15 & <=50**	**>50 & <=1000**	**>1000**
Acid Vapor	**191**	**1**	**0**	**0**	**0**	**0**

DATA SUMMARIES Continued

LLCR Shock &Vibration:

1). A total of 192 points were measured.
2). EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets.*
3). The following guidelines are used to categorize the changes in LLCR as a result from stressing.
   a. <= +5.0 mOhms: ---------- Stable
   b. +5.1 to +10.0 mOhms: ---------- Minor
   c. +10.1 to +15.0 mOhms: ---------- Acceptable
   d. +15.1 to +50.0 mOhms: ---------- Marginal
   e. +50.1 to +2000 mOhms ---------- Unstable
   f. >+2000 mOhms: ---------- Open Failure

	LLCR Measurement Summaries by Pin Type			
Date	12/4/2014	3/9/2015		
Room Temp (Deg C)	22	22		
Rel Humidity (%)	35	37		
Technician	Troy Cook	Troy Cook		
mOhm values	**Actual Initial**	**Delta Shock-Vib**	**Delta**	**Delta**
	Pin Type 1: Signal			
Average	96.00	0.82		
St. Dev.	2.10	1.42		
Min	92.33	0.00		
Max	106.04	9.39		
Summary Count	192	192		
Total Count	192	192		

LLCR Delta Count by Category						
	Stable	**Minor**	**Acceptable**	**Marginal**	**Unstable**	**Open**
mOhms	**<=5**	**>5 & <=10**	**>10 & <=15**	**>15 & <=50**	**>50 & <=1000**	**>1000**
Shock-Vib	**186**	**6**	**0**	**0**	**0**	**0**

Nanosecond Event Detection:

Shock and Vibration Event Detection Summary	
Contacts tested	60
Test Condition	C, 100g's, 6ms, Half-Sine
Shock Events	0
Test Condition	V-B, 7.56 rms g
Vibration Events	0
Total Events	0

DATA SUMMARIES Continued

Cable Pull

0 ° Pull force

	Force (lbs)
Minimum	**10.07**
Maximum	12.19
Average	11.14

90 ° Pull force

	Force (lbs)
Minimum	**8.62**
Maximum	9.14
Average	8.88

Cable Flex

IR

Pin to Pin	
Mated	
Minimum	
Initial	45000
After 500 Flex Cycles	45000

Row to Row	
Mated	
Minimum	
Initial	45000
After 500 Flex Cycles	45000

DWV

Pin to Pin	
Initial Test Voltage	Passed
After 500 Flex Cycles Test Voltage	Passed

Row to Row	
Initial Test Voltage	Passed
After 500 Flex Cycles Test Voltage	Passed

EQUIPMENT AND CALIBRATION SCHEDULES

Equipment #: HZ-TCT-01
Description: Normal force analyzer
Manufacturer: Mecmesin Multitester
Model: Mecmesin Multitester 2.5-i
Serial #: 08-1049-04
Accuracy: Last Cal: 4/26/2014, Next Cal: 4/27/2015

Equipment #: HZ-OV-01
Description: Oven
Manufacturer: Huida
Model: CS101-1E
Serial #: CS101-1E-B
Accuracy: Last Cal: 12/13/2013, Next Cal: 12/12/2014

Equipment #: HZ-THC-01
Description: Humidity transmitter
Manufacturer: Thermtron
Model: HMM30C
Serial #: D0240037
Accuracy: Last Cal: 3/1/2014, Next Cal: 2/28/2015

Equipment #: HZ-HPM-01
Description: NA9636H
Manufacturer: Ainuo
Model: 6031A
Serial #: 089601091
Accuracy: Last Cal: 3/8/2014, Next Cal: 3/7/2015

Equipment #: HZ-MO-05
Description: Micro-ohmmeter
Manufacturer: Keithley
Model: 3706
Serial #: 1285188
Accuracy: Last Cal: 11/15/2013, Next Cal: 11/14/2014

Equipment #: HZ-MO-01
Description: Multimeter /Data Acquisition System
Manufacturer: Keithley
Model: 2700
Serial #: 1199807
Accuracy: See Manual
… Last Cal: 07/01/2014, Next Cal: 06/30/2015

EQUIPMENT AND CALIBRATION SCHEDULES

Equipment #: HZ-PS-01
Description: 120 Amp Power Supply
Manufacturer: Agilent
Model: 6031A PS
Serial #: MY41000982
Accuracy: See Manual
… Last Cal: 07/02/2014, Next Cal: 07/01/2015

Equipment #: HZ-TSC-01
Description: Vertical Thermal Shock Chamber
Manufacturer: Cincinnatti Sub Zero
Model: VTS-3-6-6-SC/AC
Serial #: 10-VT14994
Accuracy: See Manual
… Last Cal: 06/28/2014, Next Cal: 06/27/2015

Equipment #: SVC-01
Description: Shock & Vibration Table
Manufacturer: Data Physics
Model: LE-DSA-10-20K
Serial #: 10037
Accuracy: See Manual
… Last Cal: 11/30/2014, Next Cal: 11/30/2015

Equipment #: ACLM-01
Description: Accelerometer
Manufacturer: PCB Piezotronics
Model: 352C03
Serial #: 115819
Accuracy: See Manual
… Last Cal: 07/09/2014, Next Cal: 07/09/2015

Equipment #: ED-03
Description: Event Detector
Manufacturer: Analysis Tech
Model: 32EHD
Serial #: 1100604
Accuracy: See Manual
… Last Cal: 06/04/2014, Next Cal: 06/04/2015

Equipment #: HPT-01
Description: Hipot Safety Tester
Manufacturer: Vitrek
Model: V73
Serial #: 019808
Accuracy:
… Last Cal: 05/15/2014, Next Cal: 05/15/2015

EQUIPMENT AND CALIBRATION SCHEDULES

Equipment #: MO-11
Description: Switch/Multimeter
Manufacturer: Keithley
Model: 3706
Serial #: 120169
Accuracy: See Manual
… Last Cal: 08/21/2014, Next Cal: 08/21/2015